

Notice of References Cited	Application/Control No. 09/892,281	Applicant(s)/Patent Under Reexamination TEIJIDO ET AL.	
	Examiner Kristin Derwich	Art Unit 2132	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,276,901	01-1994	Howell et al.	707/9
	B	US-5,765,152	06-1998	Erickson, John S.	707/9
	C	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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